

Search Notes

Application/Control No.

10/645,866

Examiner

Huy D. Nguyen

Applicant(s)/Patent under
Reexamination

SUOMI, ARTO

Art Unit

2617

| SEARCHED | | | |
|-----------------|----------|------------|----------|
| Class | Subclass | Date | Examiner |
| 455 | 435.1 | 5/5/2006 | HN |
| | 410 | | |
| | 411 | | |
| | 417 | | |
| | 434 | | |
| | 423 | | |
| | 422.1 | | |
| Updated | search | 10/16/2006 | HN |
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| INTERFERENCE SEARCHED | | | |
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| Class | Subclass | Date | Examiner |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
|--|------------|------|
| | DATE | EXMR |
| East; Text search (USPAT, US- PGPUB, EPO, JPO, DERWENT). See search history. | 5/5/2006 | HN |
| East; Text search (USPAT, US- PGPUB, EPO, JPO, DERWENT). See search history. | 10/16/2006 | HN |
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